Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/621,389	KOIKE ET AL.
Examiner	Art Unit

lves Wu

1713

SEARCHED					
Class	Subclass	Date	Examiner		
524	260-590	3/22/2005	ιwυ		
525	326.1	3/22/2005	ιwυ		
526	194,247	3/22/2005	ΙWU		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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